

BFP540FESD

NPN Silicon RF Transistor*

- For ESD protected high gain low noise amplifier
- Excellent ESD performance typical value 1000 V (HBM)
- Outstanding *G*_{ms} = 20 dB Noise Figure *F* = 0.9 dB
- SIEGET ® 45 Line
- Pb-free (ROHS compliant) package¹⁾
- Qualified according AEC Q101
- * Short term description



ESD (Electrostatic discharge) sensitive device, observe handling precaution!

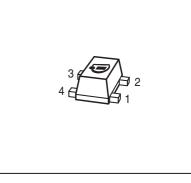
Туре	Marking	Pin Configuration			Package			
BFP540FESD	AUs	1=B	2=E	3=C	4=E	-	-	TSFP-4

Maximum Ratings

Parameter	Symbol	Value	Unit	
Collector-emitter voltage	V _{CEO}		V	
$T_{A} > 0^{\circ}C$		4.5		
$T_{A} \leq 0^{\circ}C$		4		
Collector-emitter voltage	V _{CES}	10		
Collector-base voltage	V _{CBO}	10		
Emitter-base voltage	V _{EBO}	1		
Collector current	I _C	80	mA	
Base current	I _B	8		
Total power dissipation ²⁾	P _{tot}	250	mW	
_ <i>T</i> _S ≤ 80 °C				
Junction temperature	T _i	150	°C	
Ambient temperature	T _A	-65 150		
Storage temperature	T _{stq}	-65 150		

¹Pb-containing package may be available upon special request

 $^2\mathcal{T}_S$ is measured on the collector lead at the soldering point to the pcb





Thermal Resistance

Parameter	Symbol	Value	Unit
Junction - soldering point ¹⁾	R _{thJS}	≤ 280	K/W

Electrical Characteristics at T_A = 25°C, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.]
DC Characteristics	•				•
Collector-emitter breakdown voltage	V _{(BR)CEO}	4.5	5	-	V
<i>I</i> _C = 1 mA, <i>I</i> _B = 0					
Collector-emitter cutoff current	I _{CES}	-	-	10	μA
$V_{\rm CE}$ = 10 V, $V_{\rm BE}$ = 0					
Collector-base cutoff current	I _{CBO}	-	-	100	nA
$V_{\rm CB} = 5 \text{V}, I_{\rm E} = 0$					
Emitter-base cutoff current	I _{EBO}	-	-	10	μA
$V_{\rm EB}$ = 0.5 V, $I_{\rm C}$ = 0					
DC current gain	h _{FE}	50	110	170	-
$I_{\rm C}$ = 20 mA, $V_{\rm CE}$ = 3.5 V, pulse measured					

¹For calculation of R_{thJA} please refer to Application Note Thermal Resistance



Parameter Parameter	Symbol	Values			Unit
	-	min.	typ.	max.	
AC Characteristics (verified by random sampling	j)	1			
Transition frequency	f _T	21	30	-	GHz
$I_{\rm C}$ = 50 mA, $V_{\rm CE}$ = 4 V, f = 1 GHz					
Collector-base capacitance	C _{cb}	-	0.16	0.26	pF
$V_{\rm CB} = 2 \text{V}, f = 1 \text{MHz}, V_{\rm BE} = 0 ,$					
emitter grounded					
Collector emitter capacitance	C _{ce}	-	0.4	-	
$V_{CE} = 2 V, f = 1 MHz, V_{BE} = 0$,					
base grounded					
Emitter-base capacitance	C _{eb}	-	0.55	-	
$V_{\rm EB}$ = 0.5 V, f = 1 MHz, $V_{\rm CB}$ = 0 ,					
collector grounded					
Noise figure	F				dB
$I_{\rm C}$ = 5 mA, $V_{\rm CE}$ = 2 V, f = 1.8 GHz, $Z_{\rm S}$ = $Z_{\rm Sopt}$		-	0.9	1.4	
$I_{\rm C}$ = 5 mA, $V_{\rm CE}$ = 2 V, f = 3 GHz, $Z_{\rm S}$ = $Z_{\rm Sopt}$		-	1.3	-	
Power gain, maximum stable ¹⁾	G _{ms}	-	20	-	dB
$I_{\rm C}$ = 20 mA, $V_{\rm CE}$ = 2 V, $Z_{\rm S}$ = $Z_{\rm Sopt}$,					
$Z_{\rm L} = Z_{\rm Lopt}$, $f = 1.8 {\rm GHz}$					
Power gain, maximum available ¹⁾	G _{ma}	-	14.5	-	dB
$I_{\rm C}$ = 20 mA, $V_{\rm CE}$ = 2 V, $Z_{\rm S}$ = $Z_{\rm Sopt}$,					
$Z_{\rm L} = Z_{\rm Lopt}, f = 3 {\rm GHz}$					
Transducer gain	S _{21e} ²				dB
$I_{\rm C}$ = 20 mA, $V_{\rm CE}$ = 2 V, $Z_{\rm S}$ = $Z_{\rm L}$ = 50 Ω , f = 1.8GHz		15.5	18	-	
$I_{\rm C}$ = 20 mA, $V_{\rm CE}$ = 2 V, $Z_{\rm S}$ = $Z_{\rm L}$ = 50 Ω , f = 3GHz		-	13	-	
Third order intercept point at output ²⁾	IP ₃	-	24.5	-	dBm
V_{CE} = 2 V, I_{C} = 20 mA, Z_{S} = Z_{L} = 50 Ω , f = 1.8GHz					
1dB Compression point at output	P _{-1dB}	-	11	-	1
$I_{\rm C}$ = 20 mA, $V_{\rm CE}$ = 2 V, $Z_{\rm S}$ = $Z_{\rm L}$ = 50 Ω , f = 1.8GHz					

Electrical Characteristics at $T_A = 25^{\circ}$ C, unless otherwise specified

¹ $G_{ma} = |S_{21e} / S_{12e}|$ (k-(k²-1)^{1/2}), $G_{ms} = |S_{21e} / S_{12e}|$

²IP3 value depends on termination of all intermodulation frequency components.

Termination used for this measurement is 50 Ω from 0.1 MHz to 6 GHz



SPICE Parameter

For the SPICE model as well as for S-parameters (including noise parameters) please refer to our internet website <u>www.infineon.com/rf.model</u>.

Please consult our website and download the latest versions before actually starting your design.

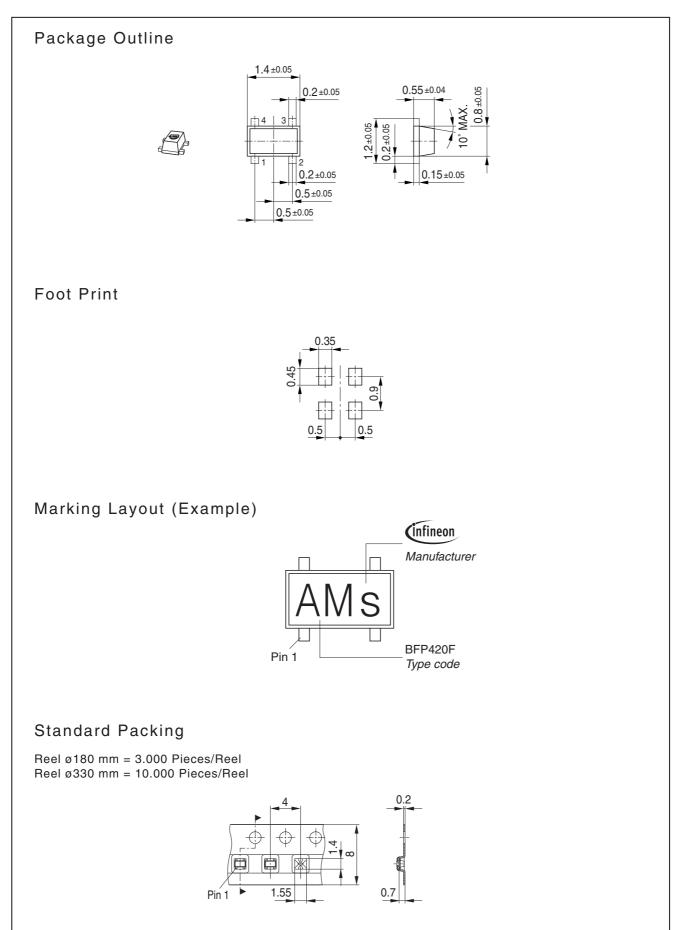
You find the BFP540FESD SPICE model in the internet in MWO- and ADS- tools very quickly and conveniently.

The simulation data have been generated and verified using typical devices.

The BFP540FESD SPICE model reflects the typical DC- and RF-performance with high accuracy.

The SPICE model of BFP540FESD will be available in Q02 / 2010.









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